SCBS737A - JULY 2000 - REVISED JULY 2000

- BiCMOS Technology With Low Quiescent Power
- Buffered Inputs
- Direct Clear Input
- 48-mA Output Sink Current
- Output Voltage Swing Limited to 3.7 V
- Controlled Output Edge Rates
- Input/Output Isolation From V_{CC}
- SCR Latch-Up-Resistant BiCMOS Process and Circuit Design
- Applications Include:
 - Buffer/Storage Registers
 - Shift Registers
 - Pattern Generators
- Package Options Include Plastic Small-Outline (M) Package and Standard Plastic (E) DIP

E OR M PACKAGE (TOP VIEW) CLR 20 VCC 1Q [] 2 19 8Q 1D 🛮 3 18 8D 2D 🛮 4 17 🛮 7D 2Q [] 5 16 7Q 3Q ∏ 6 15 ¶ 6Q 3D **1**7 14 6D 4D 🛮 8 13 5D 12 5Q 4Q **∏** 9 GND ∏ 10 11 **∏** CLK

description

The CD74FCT273 is a positive-edge-triggered, D-type flip-flop with a direct clear (\overline{CLR}) input. This device uses a small-geometry BiCMOS technology. The output stage is a combination of bipolar and CMOS transistors that limits the output high level to two diode drops below V_{CC} . This resultant lowering of output swing (0 V to 3.7 V) reduces power-bus ringing [a source of electromagnetic interference (EMI)] and minimizes V_{CC} bounce and ground bounce and their effects during simultaneous output switching. The output configuration also enhances switching speed and is capable of sinking 48 mA.

Information at the data (D) inputs meeting the setup time requirements is transferred to the Q outputs on the positive-going edge of the clock (CLK) pulse. Clock triggering occurs at a particular voltage level and is not directly related to the transition time of the positive-going pulse. When CLK is at either the high or low level, the D input has no effect at the output. All eight flip-flops are controlled by a common clock (CLK) and a common reset (CLR). The outputs are placed in a low state when CLR is taken low, independent of the CLK.

The CD74FCT273 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each flip-flop)

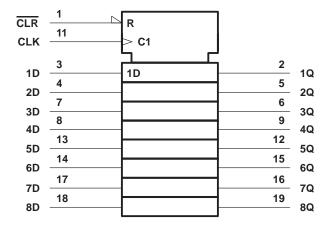
	INPUTS	INPUTS				
CLR	CLK	D	Q			
L	Х	Χ	L			
Н	\uparrow	Н	Н			
Н	\uparrow	L	L			
Н	L	Χ	Q_0			



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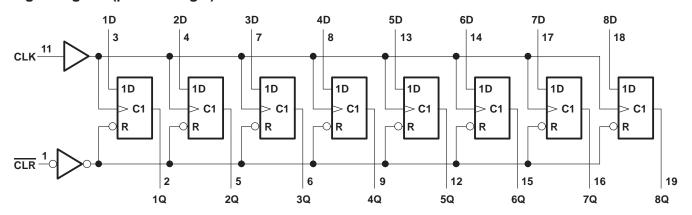


logic symbol†

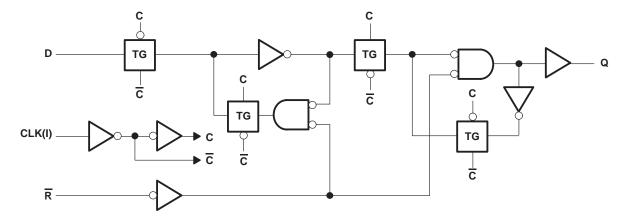


[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



logic diagram, each flip-flop (positive logic)





SCBS737A - JULY 2000 - REVISED JULY 2000

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

DC supply voltage range, V _{CC}	0.5 V to 6 V
DC input diode current, I_{IK} ($V_I < -0.5 \text{ V}$)	
DC output diode current, I_{OK} ($V_O < -0.5 \text{ V}$)	
DC output sink current per output pin, I _{OL}	
DC output source current per output pin, I _{OH}	
Continuous current through V _{CC} , I _{CC}	
Continuous current through GND	
Package thermal impedance, θ _{JA} (see Note 1): E package	69°C/W
M package	
Storage temperature range, T _{stg}	-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions (see Note 2)

		MIN	MAX	UNIT
Vcc	Supply voltage	4.75	5.25	V
VIH	High-level input voltage	2		V
V _{IL}	Low-level input voltage		0.8	V
VI	Input voltage	0	VCC	V
Vo	Output voltage	0	VCC	V
IOH	High-level output current		-15	mA
lOL	Low-level output current		48	mA
Δt/Δν	Input transition rise or fall rate	0	10	ns/V
TA	Operating free-air temperature	0	70	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vaa	T _A = 25°C		MIN	MAX	UNIT
FARAMETER	TEST CONDITIONS	vcc	MIN	MAX	IVIIIV	IVIAA	UNIT
VIK	$I_{I} = -18 \text{ mA}$	4.75 V		-1.2		-1.2	V
Voн	$I_{OH} = -15 \text{ mA}$	4.75 V	2.4		2.4		V
V _{OL}	I _{OL} = 48 mA	4.75 V		0.55		0.55	V
Ι _Ι	$V_I = V_{CC}$ or GND	5.25 V		±0.1		±1	μΑ
I _{OZ}	$V_O = V_{CC}$ or GND	5.25 V		±0.5		±10	μΑ
los [‡]	$V_I = V_{CC}$ or GND, $V_O = 0$	5.25 V	-60		-60		mA
Icc	$V_I = V_{CC}$ or GND, $I_O = 0$	5.25 V		8		80	μΑ
ΔICC§	One input at 3.4 V, Other inputs at V _{CC} or GND	5.25 V		1.6		1.6	mA
C _i	$V_I = V_{CC}$ or GND					10	pF

Not more than one output should be tested at a time, and the duration of the test should not exceed 100 ms.



NOTE 1: The package thermal impedance is calculated in accordance with JESD 51.

[§] This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or VCC.

CD74FCT273 BiCMOS OCTAL D-TYPE FLIP-FLOP WITH RESET

SCBS737A - JULY 2000 - REVISED JULY 2000

timing requirements over recommended operating conditions (unless otherwise noted) (see Figure 1)

		MIN	MAX	UNIT	
fclock	f _{clock} Clock frequency				
	Pulse duration CLR low		7		no
t _W	ruise dui ation	CLK high or low	7		ns
	Code in time	Data before CLK↑	3		no
t _{su}	Setup time	CLR before CLK↑	4		ns
th	Hold time	Data after CLK↑	2		ns

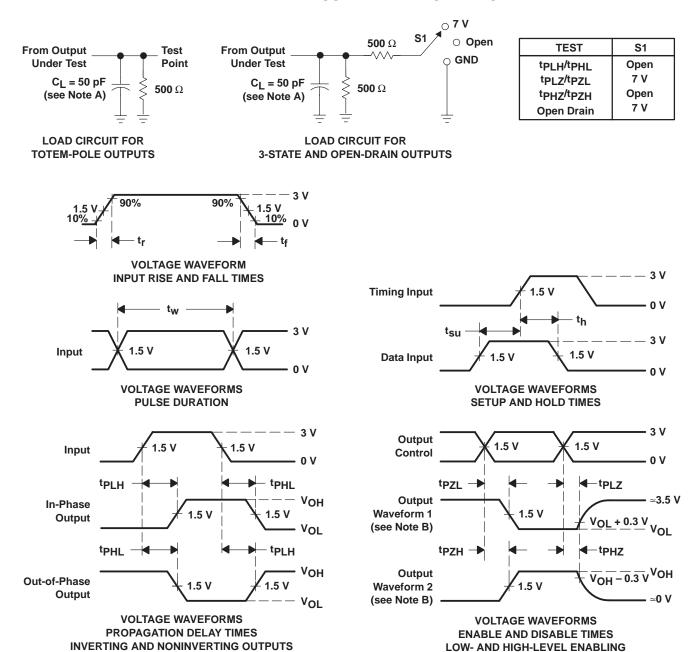
switching characteristics over recommended operating conditions, C_L = 50 pF (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	T _A = 25°C	MIN	MAX	UNIT
FARAIMETER	(INPUT)	(OUTPUT)	TYP	IVIIIN		UNIT
f _{max}				70		MHz
	CLK	A O	7	2	13	no
^t pd	CLR	Any Q	8	2	13	ns

operating characteristics, $T_A = 25^{\circ}C$

	PARAMETER 1		ONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	36	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f and t_f = 2.5 ns.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. tpLZ and tpHZ are the same as tdis.
- F. tpzL and tpzH are the same as ten.
- G. tpHL and tpLH are the same as tpd.

Figure 1. Load Circuit and Voltage Waveforms



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PACKAGING INFORMATION

Orderable part number	Status (1)	Material type	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
CD74FCT273E	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	CD74FCT273E
CD74FCT273E.A	Active	Production	PDIP (N) 20	20 TUBE	Yes	NIPDAU	N/A for Pkg Type	0 to 70	CD74FCT273E
CD74FCT273M	Obsolete	Production	SOIC (DW) 20	-	-	Call TI	Call TI	0 to 70	74FCT273M

⁽¹⁾ Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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⁽²⁾ Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

⁽³⁾ RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

⁽⁴⁾ Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

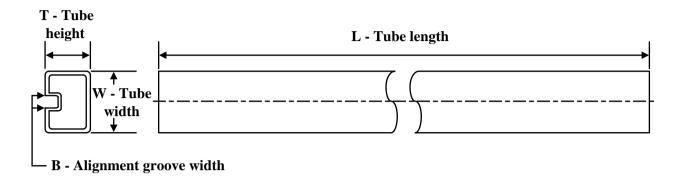
⁽⁵⁾ MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

⁽⁶⁾ Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

PACKAGE MATERIALS INFORMATION

www.ti.com 23-May-2025

TUBE



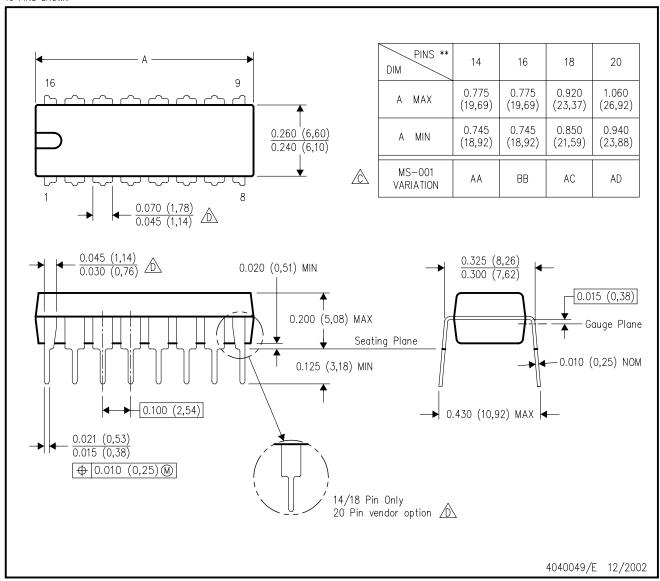
*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
CD74FCT273E	N	PDIP	20	20	506	13.97	11230	4.32
CD74FCT273E.A	N	PDIP	20	20	506	13.97	11230	4.32

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



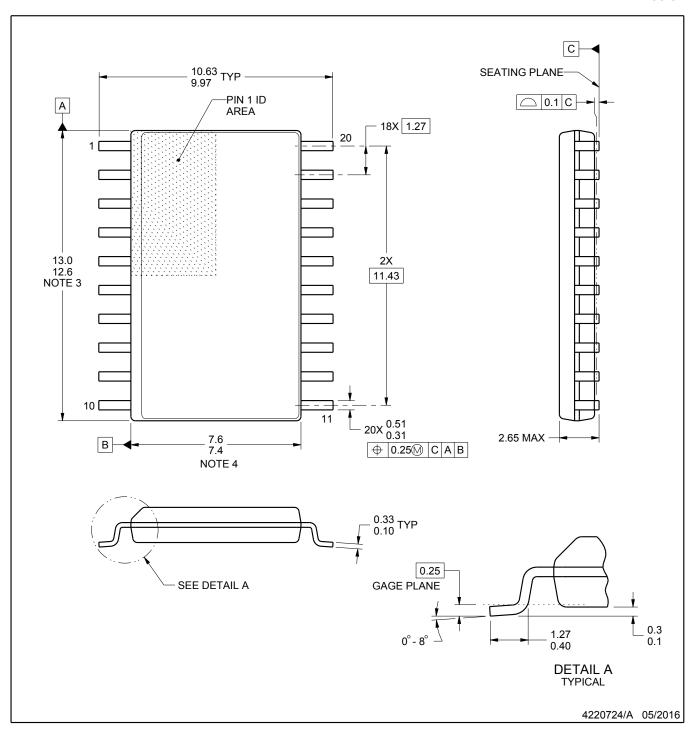
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



NOTES:

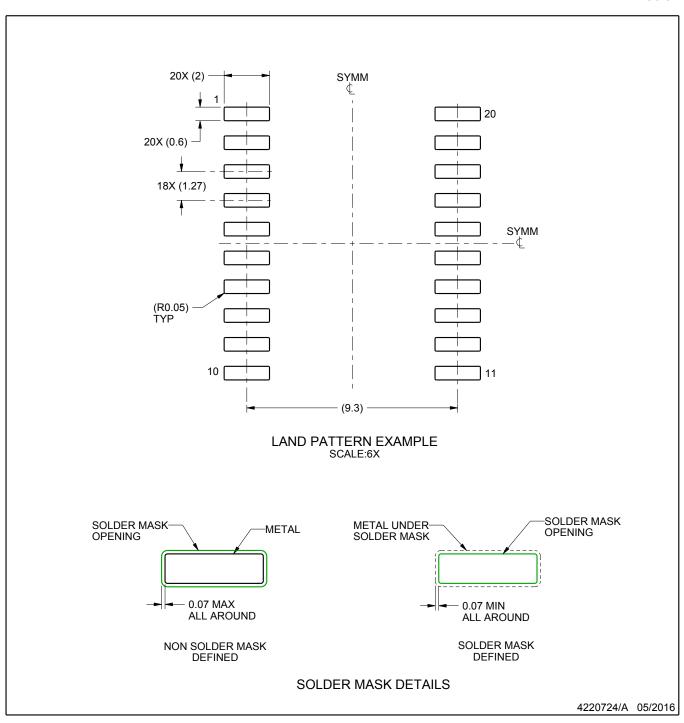
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC



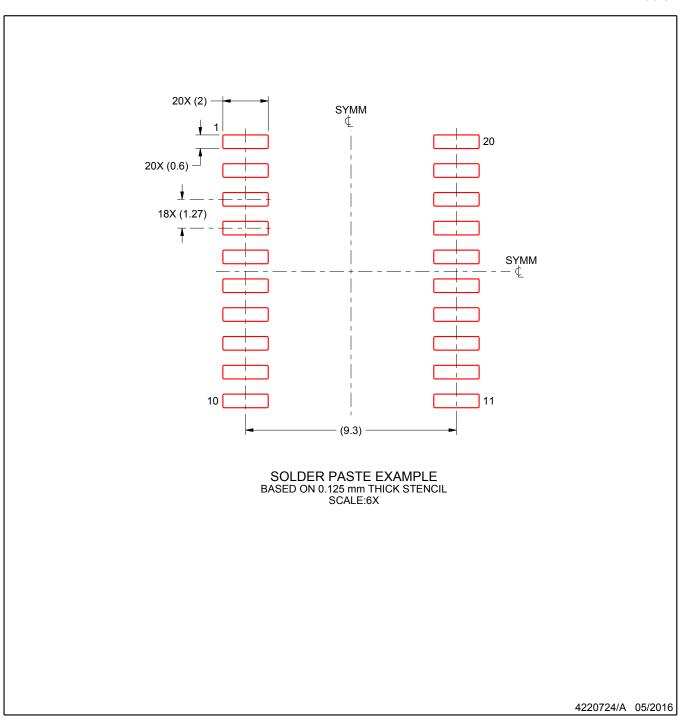
NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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